

August 1986 Revised March 2000

# **DM74LS279** Quad S-R Latch

### **General Description**

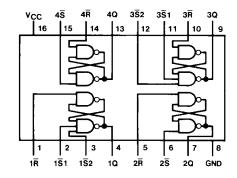
The DM74LS279 consists of four individual and independent Set-Reset Latches with active low inputs. Two of the four latches have an additional S input ANDed with the primary  $\overline{S}$  input. A LOW on any  $\overline{S}$  input while the  $\overline{R}$  input is HIGH will be stored in the latch and appear on the corresponding Q output as a HIGH. A LOW on the  $\overline{R}$  input while the S input is HIGH will clear the Q output to a LOW. Simultaneous transition of the  $\overline{R}$  and  $\overline{S}$  inputs from LOW-to-HIGH will cause the Q output to be indeterminate. Both inputs are voltage level triggered and are not affected by transition time of the input data.

# **Ordering Code:**

| Order Number | Package Number | Package Description   |  |  |  |  |
|--------------|----------------|---|--|--|--|--|
| DM74LS279M   | M16A           | 16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow |  |  |  |  |
| DM74LS279N   | N16E           | 16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide       |  |  |  |  |

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

## **Connection Diagram**



#### **Function Table**

| Inputs     | Output |            |
|------------|--------|------------|
| S (Note 1) | R      | Q          |
| L          | L      | H (Note 2) |
| L          | Н      | Н          |
| Н          | L      | L          |
| Н          | Н      | $Q_0$      |

H = HIGH Level

L = LOW Level

 $Q_0$  = The Level of Q before the indicated input conditions were established.

Note 1: For latches with double  $\overline{\mathbb{S}}$  inputs:

 $H = both \overline{S} inputs HIGH$ 

 $L = one or both \overline{S} inputs LOW$ 

Note 2: This output level is pseudo stable; that is, it may not persist when the  $\overline{S}$  and  $\overline{R}$  inputs return to their inactive (HIGH) level

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# **Absolute Maximum Ratings**(Note 3)

Supply Voltage 7V Input Voltage 7V Operating Free Air Temperature Range  $0^{\circ}\text{C to } +70^{\circ}\text{C}$  Storage Temperature Range  $-65^{\circ}\text{C to } +150^{\circ}\text{C}$ 

Note 3: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

# **Recommended Operating Conditions**

| Symbol          | Parameter                      | Min  | Nom | Max  | Units |
|-----------------|--------------------------------|------|-----|------|-------|
| V <sub>CC</sub> | Supply Voltage                 | 4.75 | 5   | 5.25 | V     |
| V <sub>IH</sub> | HIGH Level Input Voltage       | 2    |     |      | V     |
| V <sub>IL</sub> | LOW Level Input Voltage        |      |     | 0.8  | V     |
| ОН              | HIGH Level Output Current      |      |     | -0.4 | mA    |
| l <sub>OL</sub> | LOW Level Output Current       |      |     | 8    | mA    |
| T <sub>A</sub>  | Free Air Operating Temperature | 0    |     | 70   | °C    |

#### **Electrical Characteristics**

over recommended operating free air temperature range (unless otherwise noted)

| Symbol          | Parameter                         | Conditions   | Min | Typ<br>(Note 4) | Max  | Units |
|-----------------|-----------------------------------|--|-----|-----------------|------|-------|
| VI              | Input Clamp Voltage               | $V_{CC} = Min, I_I = -18 \text{ mA}$                         |     |                 | -1.5 | V     |
| V <sub>OH</sub> | HIGH Level<br>Output Voltage      | $V_{CC} = Min, I_{OH} = Max$<br>$V_{IL} = Max, V_{IH} = Min$ | 2.7 | 3.5             |      | V     |
| V <sub>OL</sub> | LOW Level<br>Output Voltage       | $V_{CC} = Min, I_{OL} = Max$<br>$V_{IL} = Max, V_{IH} = Min$ |     | 0.35            | 0.5  | V     |
|                 |                                   | I <sub>OL</sub> = 4 mA, V <sub>CC</sub> = Min                |     | 0.25            | 0.4  |       |
| I <sub>I</sub>  | Input Current @ Max Input Voltage | $V_{CC} = Max, V_I = 7V$                                     |     |                 | 0.1  | mA    |
| I <sub>IH</sub> | HIGH Level Input Current          | $V_{CC} = Max, V_I = 2.7V$                                   |     |                 | 20   | μΑ    |
| I <sub>IL</sub> | LOW Level Input Current           | $V_{CC} = Max, V_I = 0.4V$                                   |     |                 | -0.4 | mA    |
| los             | Short Circuit Output Current      | V <sub>CC</sub> = Max (Note 5)                               | -20 |                 | -100 | mA    |
| Icc             | Supply Current                    | V <sub>CC</sub> = Max (Note 6)                               |     | 3.8             | 7    | mA    |

**Note 4:** All typicals are at  $V_{CC} = 5V$ ,  $T_A = 25$ °C.

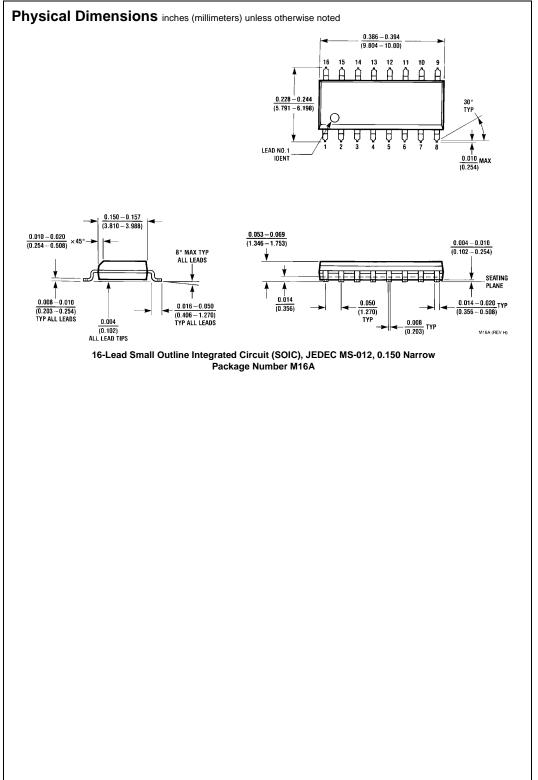
Note 5: Not more than one output should be shorted at a time, and the duration should not exceed one second.

Note 6:  $I_{CC}$  is measured with all  $\overline{R}$  inputs grounded, all  $\overline{S}$  inputs at 4.5V and all outputs OPEN.

# **Switching Characteristics**

at  $V_{CC} = 5V$  and  $T_A = 25^{\circ}C$ 

|                  |  | From (Input) | $R_L = 2 k\Omega$      |     |       |       |    |
|------------------|--|--------------|------------------------|-----|-------|-------|----|
| Symbol           | Parameter  | To (Output)  | C <sub>L</sub> = 15 pF |     | 50 pF | Units |    |
|                  |  |              | Min                    | Max | Min   | Max   |    |
| t <sub>PLH</sub> | Propagation Delay Time<br>LOW-to-HIGH Level Output | S to Q       |                        | 22  |       | 25    | ns |
| t <sub>PHL</sub> | Propagation Delay Time<br>HIGH-to-LOW Level Output | S to Q       |                        | 15  |       | 23    | ns |
| t <sub>PHL</sub> | Propagation Delay Time<br>HIGH-to-LOW Level Output | R to Q       |                        | 27  |       | 33    | ns |



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#### Physical Dimensions inches (millimeters) unless otherwise noted (Continued) 0.740 - 0.780 0.090 (18.80 - 19.81)(2.286)**16 15 14 13 12 11 10 9** 16 T5 F INDEX AREA 0.250 ± 0.010 $(6.350 \pm 0.254)$ PIN NO. 1 PIN NO. 1 1 2 3 4 5 6 7 8 1 2 \_ OPTION 01 OPTION 02 0.065 $\frac{0.130 \pm 0.005}{(3.302 \pm 0.127)}$ $\frac{0.060}{(1.524)}$ TYP (1.651)4° TYP 0.300 - 0.320OPTIONAL (7.620 - 8.128) 0.145 - 0.200 $\overline{(3.683 - 5.080)}$ 95°±5° $\frac{0.008 - 0.016}{(0.203 - 0.406)}$ TYP 90° ± 4° TYP 0.020 $\frac{0.280}{(7.112)}$ MIN (0.508)0.125 - 0.150 (3.175 - 3.810) $0.030 \pm 0.015$ $(0.762 \pm 0.381)$ 0.014 - 0.023 0.100 ± 0.010 (0.325 +0.040 -0.015 (0.356 - 0.584) $(2.540 \pm 0.254)$ 0.050 ± 0.010 N16E (REV F)

16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N16E

(1.270 ± 0.254)

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